

Notice of References Cited	Application/Control No. 10/644,993	Applicant(s)/Patent Under Reexamination CHANG ET AL.	
	Examiner Tom V. Sheng	Art Unit 2629	Page 1 of 1

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*	B	US-2004/0075971	04-2004	Tseng et al.	361/681
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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